


<b>Search Notes</b>  	<b>Application/Control No.</b>  10773610	<b>Applicant(s)/Patent Under Reexamination</b>  YAMANAKA ET AL.
	<b>Examiner</b>  Emmanuel Bayard	<b>Art Unit</b>  2611

SEARCHED			
Class	Subclass	Date	Examiner
375	229, 232, 233, 262, 265, 346, 350, 260	7/7/2010	EB

SEARCH NOTES		
Search Notes	Date	Examiner
East	7/7/2010	EB

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
375	350, 346, 260	7/7/2010	EB

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